

<b>Notice of References Cited</b>	Application/Control No. 10/781,878		Applicant(s)/Patent Under Reexamination SHINOMIYA, KIYOSHI	
	Examiner MICHAEL E. KEEFER		Art Unit 2454	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N	JP 2000115197 A	04-2000	Japan	SAI, MEIJU	
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#### NON-PATENT DOCUMENTS

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	U	Translated Abstract JP 2000115197 A, published April 21, 2000.
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